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# Understanding <u>Embedded - FPGAs (Field Programmable Gate Array)</u>

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

#### **Applications of Embedded - FPGAs**

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details	
Product Status	Obsolete
Number of LABs/CLBs	138
Number of Logic Elements/Cells	1100
Total RAM Bits	65536
Number of I/O	12
Number of Gates	-
Voltage - Supply	1.14V ~ 1.26V
Mounting Type	Surface Mount
Operating Temperature	-40°C ~ 100°C (TJ)
Package / Case	20-UFBGA, WLCSP
Supplier Device Package	20-WLCSP (1.71x2.06)
Purchase URL	https://www.e-xfl.com/product-detail/lattice-semiconductor/ice5lp1k-uwg20itr50

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong



Table 1-1. iCE40 Ultra Family Selection Guide

Part Number	iCE5LP1K	iCE5LP2K	iCE5LP4K
Logic Cells (LUT + Flip-Flop)	1100	2048	3520
EBR Memory Blocks	16	20	20
EBR Memory Bits	64 k	80 k	80 k
PLL Block	1	1	1
NVCM	Yes	Yes	Yes
DSP Blocks (MULT16 with 32-bit Accumulator)	2	4	4
Hardened I2C, SPI	1,1	2,2	2,2
HF Oscillator (48 MHz)	1	1	1
LF Oscillator (10 kHz)	1	1	1
24 mA LED Sink	3	3	3
500 mA LED Sink	1	1	1
Embedded PWM IP	Yes	Yes	No
Packages, ball pitch, dimension		Total User I/O Count	•
36-ball WLCSP, 0.35 mm, 2.078 mm x 2.078 mm	26	26	26
36-ball ucfBGA, 0.40 mm, 2.5 mm x 2.5 mm	26	26	26
48-ball QFN Package, 0.5 mm, 7.0 mm x 7.0 mm	39	39	39

### Introduction

The iCE40 Ultra family of ultra-low power FPGAs has three devices with densities ranging from 1100 to 3520 Look-Up Tables (LUTs) fabricated in a 40 nm Low Power CMOS process. In addition to LUT-based, low-cost programmable logic, these devices also feature Embedded Block RAM (EBR), on-chip Oscillators (LFOSC, HFOSC), two hardened I<sup>2</sup>C Controllers, two hardened SPI Controllers, three 24 mA RGB LED open-drain drivers, a 500 mA IR LED open-drain drivers, and DSP blocks. These features allow the devices to be used in low-cost, high-volume consumer and mobile applications.

The iCE40 Ultra FPGAs are available in very small form factor packages, as small as 2.078 mm x 2.078 mm. The small form factor allows the device to easily fit into a lot of mobile applications, where space can be limited. Table 1-1 shows the LUT densities, package and I/O pin count.

The iCE40 Ultra devices offer I/O features such as pull-up resistors. Pull-up features are controllable on a "per-pin" basis.

The iCE40 Ultra devices also provide flexible, reliable and secure configuration from on-chip NVCM. These devices can also configure themselves from external SPI Flash, or be configured by an external master such as a CPU.

Lattice provides a variety of design tools that allow complex designs to be efficiently implemented using the iCE40 Ultra family of devices. Popular logic synthesis tools provide synthesis library support for iCE40 Ultra. Lattice design tools use the synthesis tool output along with the user-specified preferences and constraints to place and route the design in the iCE40 Ultra device. These tools extract the timing from the routing and back-annotate it into the design for timing verification.

Lattice provides in the iCE40 Ultra 1K and 2K device the embedded RGB PWM IP at no extra cost of LUT available to the user, to perform controlling the RGB LED function. This embedded IP allow users to control color, LED ON/OFF time, and breathe rate of the LED. For more information, please refer to Usage Guide in Lattice Design Software.

Lattice provides many pre-engineered IP (Intellectual Property) modules, including a number of reference designs, licensed free of charge, optimized for the iCE40 Ultra FPGA family. Lattice also can provide fully verified bitstream for some of the widely used target functions in mobile device applications, such as ultra-low power sensor management, gesture recognition, IR remote, barcode emulator functions. Users can use these functions as offered by Lattice, or they can use the design to create their own unique required functions. For more information regarding Lattice's reference designs or fully-verified bitstreams, please contact your local Lattice representative.



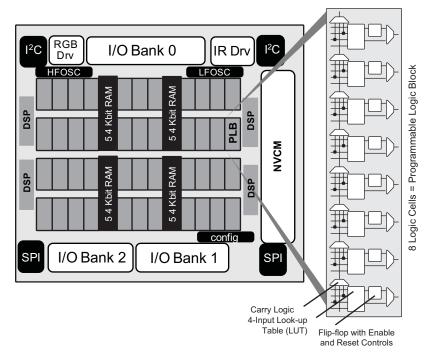
# iCE40 Ultra Family Data Sheet Architecture

June 2016 Data Sheet DS1048

### **Architecture Overview**

The iCE40 Ultra family architecture contains an array of Programmable Logic Blocks (PLB), two Oscillator Generators, two user configurable I<sup>2</sup>C controllers, two user configurable SPI controllers, and blocks of sysMEM<sup>™</sup> Embedded Block RAM (EBR) surrounded by Programmable I/O (PIO). Figure 2-1shows the block diagram of the iCE5LP-4K device.

Figure 2-1. iCE5LP-4K Device, Top View



The Programmable Logic Blocks (PLB) and sysMEM EBR blocks, are arranged in a two-dimensional grid with rows and columns. Each column has either PLB or EBR blocks. The PIO cells are located at the top and bottom of the device, arranged in banks. The PLB contains the building blocks for logic, arithmetic, and register functions. The PIOs utilize a flexible I/O buffer referred to as a sysIO buffer that supports operation with a variety of interface standards. The blocks are connected with many vertical and horizontal routing channel resources. The place and route software tool automatically allocates these routing resources.

In the iCE40 Ultra family, there are three sysIO banks, one on top and two at the bottom. User can connect some  $V_{\text{CCIOS}}$  together, if all the I/Os are using the same voltage standard. Refer to the details in later sections of this document on Power Up Sequence. The sysMEM EBRs are large 4 kbit, dedicated fast memory blocks. These blocks can be configured as RAM, ROM or FIFO with user logic using PLBs.

Every device in the family has two user SPI ports, one of these (right side) SPI port also supports programming and configuration of the device. The iCE40 Ultra also includes two user I<sup>2</sup>C ports, two Oscillators, and high current RGB and IR LED sinks.

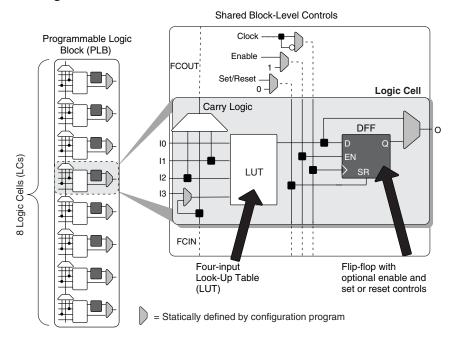
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#### **PLB Blocks**

The core of the iCE40 Ultra device consists of Programmable Logic Blocks (PLB) which can be programmed to perform logic and arithmetic functions. Each PLB consists of eight interconnected Logic Cells (LC) as shown in Figure 2-2. Each LC contains one LUT and one register.

Figure 2-2. PLB Block Diagram



#### **Logic Cells**

Each Logic Cell includes three primary logic elements shown in Figure 2-2.

- A four-input Look-Up Table (LUT) builds any combinational logic function, of any complexity, requiring up to four inputs. Similarly, the LUT element behaves as a 16x1 Read-Only Memory (ROM). Combine and cascade multiple LUTs to create wider logic functions.
- A 'D'-style Flip-Flop (DFF), with an optional clock-enable and reset control input, builds sequential logic functions. Each DFF also connects to a global reset signal that is automatically asserted immediately following device configuration.
- Carry Logic boosts the logic efficiency and performance of arithmetic functions, including adders, subtracters, comparators, binary counters and some wide, cascaded logic functions.

Table 2-1. Logic Cell Signal Descriptions

Function	Туре	Signal Names	Description
Input	Data signal	10, 11, 12, 13	Inputs to LUT
Input	Control signal	Enable	Clock enable shared by all LCs in the PLB
Input	Control signal	Set/Reset <sup>1</sup>	Asynchronous or synchronous local set/reset shared by all LCs in the PLB.
Input	Control signal	Clock	Clock one of the eight Global Buffers, or from the general-purpose interconnects fabric shared by all LCs in the PLB
Input	Inter-PLB signal	FCIN	Fast carry in
Output	Data signals	0	LUT or registered output
Output	Inter-PFU signal	FCOUT	Fast carry out

<sup>1.</sup> If Set/Reset is not used, then the flip-flop is never set/reset, except when cleared immediately after configuration.



### sysCLOCK Phase Locked Loops (PLLs)

The sysCLOCK PLLs provide the ability to synthesize clock frequencies. The iCE40 Ultra devices have one sys-CLOCK PLL. REFERENCECLK is the reference frequency input to the PLL and its source can come from an external I/O pin, the internal Oscillator Generators from internal routing. EXTFEEDBACK is the feedback signal to the PLL which can come from internal routing or an external I/O pin. The feedback divider is used to multiply the reference frequency and thus synthesize a higher frequency clock output.

The PLLOUT output has an output divider, thus allowing the PLL to generate different frequencies for each output. The output divider can have a value from 1 to 64 (in increments of 2X). The PLLOUT outputs can all be used to drive the iCE40 Ultra global clock network directly or general purpose routing resources can be used.

The LOCK signal is asserted when the PLL determines it has achieved lock and de-asserted if a loss of lock is detected. A block diagram of the PLL is shown in Figure 2-3.

The timing of the device registers can be optimized by programming a phase shift into the PLLOUT output clock which will advance or delay the output clock with reference to the REFERENCECLK clock. This phase shift can be either programmed during configuration or can be adjusted dynamically. In dynamic mode, the PLL may lose lock after a phase adjustment on the output used as the feedback source and not relock until the tLOCK parameter has been satisfied.

There is an additional feature in the iCE40 Ultra PLL. There are 2 FPGA controlled inputs, SCLK and SDI, that allows the user logic to serially shift in data thru SDI, clocked by SCLK clock. The data shifted in would change the configuration settings of the PLL. This feature allows the PLL to be time multiplexed for different functions, with different clock rates. After the data is shifted in, user would simply pulse the RESET input of the PLL block, and the PLL will re-lock with the new settings. For more details, please refer to TN1251, iCE40 sysCLOCK PLL Design and Usage Guide.

Figure 2-3. PLL Diagram

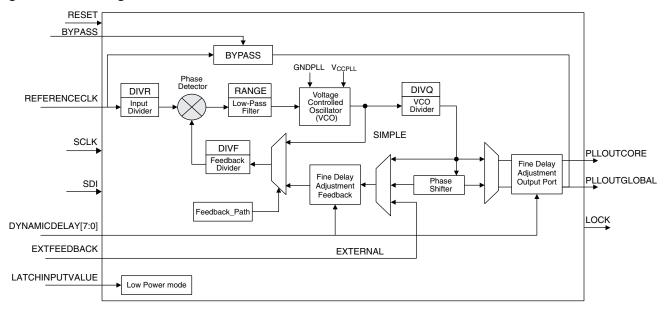


Table 2-3 provides signal descriptions of the PLL block.



### Table 2-3. PLL Signal Descriptions

Signal Name	Direction	Description
REFERENCECLK	Input	Input reference clock
BYPASS	Input	The BYPASS control selects which clock signal connects to the PLL-OUT output.  0 = PLL generated signal 1 = REFERENCECLK
EXTFEEDBACK	Input	External feedback input to PLL. Enabled when the FEEDBACK_PATH attribute is set to EXTERNAL.
DYNAMICDELAY[7:0]	Input	Fine delay adjustment control inputs. Enabled when DELAY_ADJUSTMENT_MODE is set to DYNAMIC.
LATCHINPUTVALUE	Input	When enabled, puts the PLL into low-power mode; PLL output is held static at the last input clock value. Set ENABLE ICEGATE_PORTA and PORTB to '1' to enable.
PLLOUTGLOBAL	Output	Output from the Phase-Locked Loop (PLL). Drives a global clock network on the FPGA. The port has optimal connections to global clock buffers GBUF4 and GBUF5.
PLLOUTCORE	Output	Output clock generated by the PLL, drives regular FPGA routing. The frequency generated on this output is the same as the frequency of the clock signal generated on the PLLOUTLGOBAL port.
LOCK	Output	When High, indicates that the PLL output is phase aligned or locked to the input reference clock.
RESET	Input	Active low reset.
SCLK	Input	Input, Serial Clock used for re-programming PLL settings.
SDI	Input	Input, Serial Data used for re-programming PLL settings.

### sysMEM Embedded Block RAM Memory

Larger iCE40 Ultra device includes multiple high-speed synchronous sysMEM Embedded Block RAMs (EBRs), each 4 kbit in size. This memory can be used for a wide variety of purposes including data buffering, and FIFO.

#### sysMEM Memory Block

The sysMEM block can implement single port, pseudo dual port, or FIFO memories with programmable logic resources. Each block can be used in a variety of depths and widths as shown in Table 2-4.



#### sysDSP

The iCE40 Ultra family provides an efficient sysDSP architecture that is very suitable for low-cost Digital Signal Processing (DSP) functions for mobile applications. Typical functions used in these applications are Multiply, Accumulate, and Multiply-Accumulate. The block can also be used for simple Add and Subtract functions.

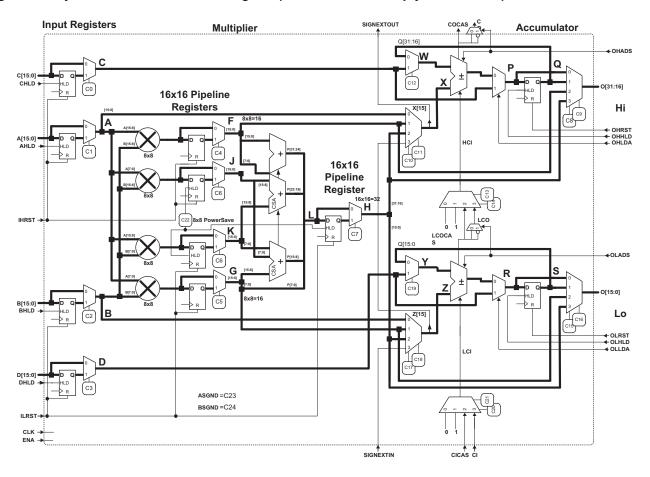
#### iCE40 Ultra sysDSP Architecture Features

The iCE40 Ultra sysDSP supports many functions that include the following:

- Single 16-bit x 16-bit Multiplier, or two independent 8-bit x 8-bit Multipliers
- Optional independent pipeline control on Input Register, Output Register, and Intermediate Reg faster clock performance
- Single 32-bit Accumulator, or two independent 16-bit Accumulators
- Single 32-bit, or two independent 16-bit Adder/Subtracter functions, registered or asynchronous
- · Cascadable to create wider Accumulator blocks

Figure 2-5 shows the block diagram of the sysDSP block. The block consists Multiplier section, with an bypassable Output register. The Input Register, Intermediate register between Multiplier and AC timing to achieve the highest performance.

Figure 2-5. sysDSP Functional Block Diagram (16-bit x 16-bit Multiply-Accumulate)





Signal	Primitive Port Name	Width	Input / Output	Function	Default
OHLDA	OLOADTOP	1	Input	High-order (upper half) Accumulator Register Accumulate/Load control. 0 = Accumulate, register is loaded with Adder/Sub- tracter results 1 = Load, register is loaded with Input C or C Reg- ister	0: Accumulate
OHADS	ADDSUBTOP	1	Input	High-order (upper half) Accumulator Add or Subtract select.  0 = Add 1 = Subtract	0: Add
OLHLD	OHOLDBOT	1	Input	Low-order (lower half) Accumulator Register Hold.  0 = Update 1 = Hold	0: Update
OLRST	ORSTBOT	1	Input	Reset input to Low-order (lower half) bits of the Accumulator Register.  0 =No Reset  1 = Reset	0: No Reset
OLLDA	OLOADBOT	1	Input	Low-order (lower half) Accumulator Register Accumulate/Load control.  0 = Accumulate, register is loaded with Adder/Subtracter results  1 = Load, register is loaded with Input C or C Register	0: Accumulate
OLADS	ADDSUBBOT	1	Input	Low-order (lower half) Accumulator Add or Subtract select.  0 = Add 1 = Subtract	0: Add
CICAS	ACCUMCI	1	Input	Cascade Carry/Borrow input from previous sys- DSP block	
CI	CI	1	Input	Carry/Borrow input from lower logic tile	
COCAS	ACCUMCO	1	Output	Cascade Carry/Borrow output to next sysDSP block	
СО	CO	1	Output	Carry/Borrow output to higher logic tile	
SIGNEXTIN	SIGNEXTIN	1	Input	Sign extension input from previous sysDSP block	
SIGNEXTOUT	SIGNEXTOUT	1	Output	Sing extension output to next sysDSP block	

The iCE40 Ultra sysDSP can support the following functions:

- 8-bit x 8-bit Multiplier
- 16-bit x 16-bit Multiplier
- 16-bit Adder/Subtracter
- 32-bit Adder/Subtracter
- 16-bit Accumulator
- 32-bit Accumulator
- 8-bit x 8-bit Multiply-Accumulate
- 16-bit x 16-bit Multiply-Accumulate

Figure 2-6 shows the path for an 8-bit x 8-bit Multiplier using the upper half of sysDSP block.



Figure 2-7. DSP 16-bit x 16-bit Multiplier

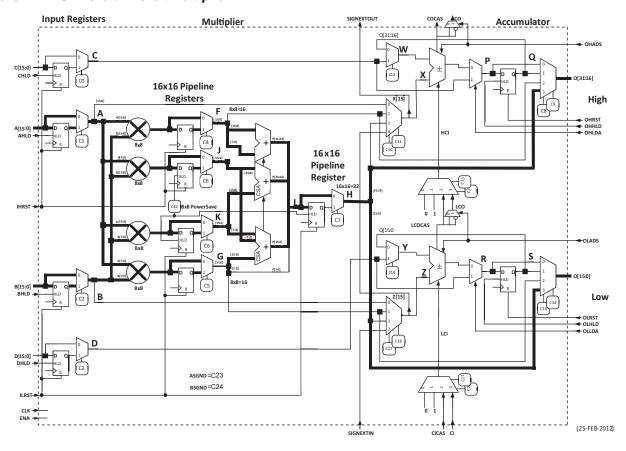




Figure 2-9. iCE I/O Register Block Diagram

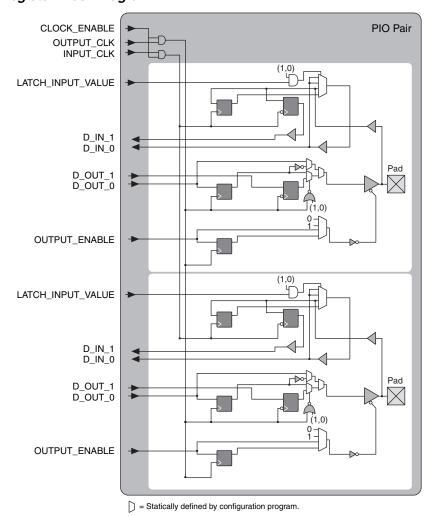


Table 2-7. PIO Signal List

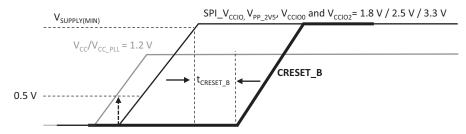
Pin Name	I/O Type	Description
OUTPUT_CLK	Input	Output register clock
CLOCK_ENABLE	Input	Clock enable
INPUT_CLK	Input	Input register clock
OUTPUT_ENABLE	Input	Output enable
D_OUT_0/1	Input	Data from the core
D_IN_0/1	Output	Data to the core
LATCH_INPUT_VALUE	Input	Latches/holds the Input Value

### sysIO Buffer

Each I/O is associated with a flexible buffer referred to as a sysIO buffer. These buffers are arranged around the periphery of the device in groups referred to as banks. The sysIO buffers allow users to implement a wide variety of standards that are found in today's systems with LVCMOS interfaces.



Figure 3-2. Power Up Sequence with All Supplies Connected Together



# Power-On-Reset Voltage Levels<sup>1</sup>

Symbol	Parameter			Max.	Units
	December 2012	V <sub>CC</sub>	0.62	0.92	V
V <sub>PORUP</sub>	Power-On-Reset ramp-up trip point (circuit monitoring V <sub>CC</sub> , SPI_V <sub>CCIO1</sub> , V <sub>PP 2V5</sub> )	SPI_V <sub>CCIO1</sub>	0.87	1.50	V
	1 00, 51 = 1 00101, 1 FF_2V5/	$V_{PP\_2V5}$	0.90	1.53	V
	Devices On Depart some device this point (since it mornitors	$V_{CC}$	_	0.79	V
V <sub>PORDN</sub>	Power-On-Reset ramp-down trip point (circuit monitoring V <sub>CC</sub> , SPI_V <sub>CCIO1</sub> , V <sub>PP 2V5</sub> )	SPI_V <sub>CCIO1</sub>		1.50	V
		$V_{PP\_2V5}$	_	1.53	V

<sup>1.</sup> These POR trip points are only provided for guidance. Device operation is only characterized for power supply voltages specified under recommended operating conditions.

### **ESD Performance**

Please contact Lattice Semiconductor for additional information.

### **DC Electrical Characteristics**

#### **Over Recommended Operating Conditions**

Symbol	Parameter	Condition	Min.	Тур.	Max.	Units
I <sub>IL,</sub> I <sub>IH</sub> 1, 3, 4	Input or I/O Leakage	$0V < V_{IN} < V_{CCIO} + 0.2 V$	_	_	+/-10	μΑ
C <sub>1</sub>	I/O Capacitance, excluding LED Drivers <sup>2</sup>	$V_{CCIO} = 3.3 \text{ V}, 2.5 \text{ V}, 1.8 \text{ V}$ $V_{CC} = \text{Typ.}, V_{IO} = 0 \text{ to } V_{CCIO} + 0.2 \text{ V}$	_	6		pF
C <sub>2</sub>	Global Input Buffer Capacitance <sup>2</sup>	$V_{CCIO} = 3.3 \text{ V}, 2.5 \text{ V}, 1.8 \text{ V}$ $V_{CC} = \text{Typ.}, V_{IO} = 0 \text{ to } V_{CCIO} + 0.2 \text{ V}$	_	6		pF
C <sub>3</sub>	RGB Pin Capacitance <sup>2</sup>	$V_{CC}$ = Typ., $V_{IO}$ = 0 to 3.5 V	_	15		pF
C <sub>4</sub>	IRLED Pin Capacitance <sup>2</sup>	$V_{CC}$ = Typ., $V_{IO}$ = 0 to 3.5 V	_	53		pF
V <sub>HYST</sub>	Input Hysteresis	V <sub>CCIO</sub> = 1.8 V, 2.5 V, 3.3 V	_	200	_	mV
	latera al DIO Dellera	$V_{CCIO} = 1.8 \text{ V}, 0 = < V_{IN} < = 0.65 V_{CCIO}$	-3	_	-31	μΑ
I <sub>PU</sub>	Internal PIO Pull-up Current	$V_{CCIO} = 2.5 \text{ V}, 0 = < V_{IN} < = 0.65 V_{CCIO}$	-8	_	-72	μΑ
		$V_{CCIO} = 3.3 \text{ V}, 0 = < V_{IN} < = 0.65 V_{CCIO}$	-11	_	-128	μΑ

<sup>1.</sup> Input or I/O leakage current is measured with the pin configured as an input or as an I/O with the output driver tri-stated. It is not measured with the output driver active. Internal pull-up resistors are disabled.

<sup>2.</sup> T<sub>J</sub> 25 °C, f = 1.0 MHz.

<sup>3.</sup> Please refer to V<sub>IL</sub> and V<sub>IH</sub> in the sysIO Single-Ended DC Electrical Characteristics table of this document.

<sup>4.</sup> Input pins are clamped to V<sub>CCIO</sub> and GND by a diode. When input is higher than V<sub>CCIO</sub> or lower than GND, the Input Leakage current will be higher than the I<sub>IL</sub> and I<sub>IH</sub>.



# Supply Current 1, 2, 3, 4, 5

Symbol	Parameter	Typ. V <sub>CC</sub> = 1.2 V <sup>4</sup>	Units
I <sub>CCSTDBY</sub>	Core Power Supply Static Current	71	μΑ
I <sub>PP2V5STDBY</sub>	V <sub>PP_2V5</sub> Power Supply Static Current	0.55	μΑ
I <sub>SPI_VCCIO1STDBY</sub>	SPI_V <sub>CCIO1</sub> Power Supply Static Current	0.5	μΑ
ICCIOSTDBY	V <sub>CCIO</sub> Power Supply Static Current	0.5	μΑ
I <sub>CCPEAK</sub>	Core Power Supply Startup Peak Current	8.0	mA
I <sub>PP_2V5PEAK</sub>	V <sub>PP_2V5</sub> Power Supply Startup Peak Current	7.0	mA
I <sub>SPI_VCCIO1PEAK</sub>	SPI_V <sub>CCIO1</sub> Power Supply Startup Peak Current	9.0	mA
ICCIOPEAK	V <sub>CCIO</sub> Power Supply Startup Peak Current	7.5	mA

Assumes blank pattern with the following characteristics: all outputs are tri-stated, all inputs are configured as LVCMOS and held at V<sub>CCIO</sub> or GND, on-chip PLL is off. For more detail with your specific design, use the Power Calculator tool. Power specified with master SPI configuration mode. Other modes may be up to 25% higher.

- 2. Frequency = 0 MHz.
- 3. TJ = 25 °C, power supplies at nominal voltage, on devices processed in nominal process conditions.
- 4. Does not include pull-up.
- 5. Startup Peak Currents are measured with decoupling capacitance of 0.1 uF, 10 nF, and 1 nF to the power supply. Higher decoupling capacitance causes higher current.

# **User I<sup>2</sup>C Specifications**

Parameter		spec (STD Mode)			spec (FAST Mode)			
Symbol	Parameter Description	Min	Тур	Max	Min	Тур	Max	Units
f <sub>SCL</sub>	Maximum SCL clock frequency	_	_	100	_	_	400	kHz
t <sub>HI</sub>	SCL clock HIGH Time	4	_	_	0.6	_	_	μs
t <sub>LO</sub>	SCL clock LOW Time	4.7	_		1.3		_	μs
t <sub>SU,DAT</sub>	Setup time (DATA)	250	_		100		_	ns
t <sub>HD,DAT</sub>	Hold time (DATA)	0	_		0	_	_	ns
t <sub>SU,STA</sub>	Setup time (START condition)	4.7	_	_	0.6	_	_	μs
t <sub>HD,STA</sub>	Hold time (START condition)	4	_	_	0.6	_	_	μs
t <sub>SU,STO</sub>	Setup time (STOP condition)	4	_		0.6		_	μs
t <sub>BUF</sub>	Bus free time between STOP and START	4.7	_	_	1.3	_	_	μs
t <sub>CO,DAT</sub>	SCL LOW to DATAOUT valid	-	_	3.4	<u> </u>	<u> </u>	0.9	μs

# User SPI Specifications<sup>1, 2</sup>

Parameter Symbol	Parameter Description	Min	Тур	Max	Units
$f_{MAX}$	Maximum SCK clock frequency			45	MHz

<sup>1.</sup> All setup and hold time parameters on external SPI interface are design-specific and, therefore, generated by the Lattice Design Software tools. These parameters include the following:

t<sub>SUmaster</sub> master Setup time (master mode)
 t<sub>HOLDmaster</sub> master Hold time (master mode)
 t<sub>SUslave</sub> slave Setup time (slave mode)
 t<sub>HOLDslave</sub> slave Hold time (slave mode)
 t<sub>SCK2OUT</sub> SCK to out (slave mode)

<sup>2.</sup> The SCLK duty cycle needs to be specified in the Lattice Design Software as a timing constraint in order to ensure proper timing check on SCLK HIGH and LOW (t<sub>HI</sub>, t<sub>LO</sub>) time.



# Typical Building Block Function Performance<sup>1, 2</sup>

### **Pin-to-Pin Performance (LVCMOS25)**

Function	Timing	Units
Basic Functions	•	
16-bit decoder	16.5	ns
4:1 MUX	18.0	ns
16:1 MUX	19.5	ns

### **Register-to-Register Performance**

Function	Timing	Units			
Basic Functions					
16:1 MUX	110	MHz			
16-bit adder	100	MHz			
16-bit counter	100	MHz			
64-bit counter	40	MHz			
Embedded Memory Functions		,			
256x16 Pseudo-Dual Port RAM	150	MHz			

The above timing numbers are generated using the Lattice Design Software tool. Exact performance may
vary with device and tool version. The tool uses internal parameters that have been characterized but are not
tested on every device.

### **Derating Logic Timing**

Logic timing provided in the following sections of the data sheet and the Lattice design tools are worst case numbers in the operating range. Actual delays may be much faster. Lattice design tools can provide logic timing numbers at a particular temperature and voltage.

# Maximum sysIO Buffer Performance<sup>1</sup>

I/O Standard	Max. Speed	Units		
	Inputs			
LVCMOS33	250	MHz		
LVCMOS25	250	MHz		
LVCMOS18	250	MHz		
Outputs				
LVCMOS33	250	MHz		
LVCMOS25	250	MHz		
LVCMOS18	155	MHz		

<sup>1.</sup> Measured with a toggling pattern

<sup>2.</sup> Under worst case operating conditions.



# iCE40 Ultra Family Timing Adders

### Over Recommended Commercial Operating Conditions<sup>1, 2, 3</sup>

Buffer Type Description		Timing (Typ.)	Units
Input Adjusters	·		
LVCMOS33	LVCMOS, V <sub>CCIO</sub> = 3.3 V	0.18	ns
LVCMOS25	LVCMOS, V <sub>CCIO</sub> = 2.5 V	0	ns
LVCMOS18	LVCMOS, V <sub>CCIO</sub> = 1.8 V	0.19	ns
Output Adjusters	·		
LVCMOS33	LVCMOS, V <sub>CCIO</sub> = 3.3 V	-0.12	ns
LVCMOS25	LVCMOS, V <sub>CCIO</sub> = 2.5 V	0	ns
LVCMOS18	LVCMOS, V <sub>CCIO</sub> = 1.8 V	1.32	ns

<sup>1.</sup> Timing adders are relative to LVCMOS25 and characterized but not tested on every device.

# iCE40 Ultra External Switching Characteristics

### **Over Recommended Commercial Operating Conditions**

Parameter	Description	Device	Min	Max	Units
Clocks				I	1
Global Clocks					
f <sub>MAX_GBUF</sub>	Frequency for Global Buffer Clock network	All devices	_	185	MHz
t <sub>W_GBUF</sub>	Clock Pulse Width for Global Buffer	All devices	2	_	ns
t <sub>SKEW_GBUF</sub>	Global Buffer Clock Skew Within a Device	All devices	_	500	ps
Pin-LUT-Pin Prop	agation Delay				
t <sub>PD</sub>	Best case propagation delay through one LUT logic	All devices	_	9.0	ns
General I/O Pin P	arameters (Using Global Buffer Clock without F	PLL)1	<b>"</b>	•	
t <sub>SKEW_IO</sub>	Data bus skew across a bank of IOs	All devices	_	410	ps
t <sub>CO</sub>	Clock to Output – PIO Output Register	All devices	_	9.0	ns
t <sub>SU</sub>	Clock to Data Setup - PIO Input Register	All devices	-0.5	_	ns
t <sub>H</sub>	Clock to Data Hold – PIO Input Register	All devices	5.55	_	ns
General I/O Pin P	arameters (Using Global Buffer Clock with PLL)	)			
t <sub>COPLL</sub>	Clock to Output - PIO Output Register	All Devices	_	2.9	ns
t <sub>SUPLL</sub>	Clock to Data Setup - PIO Input Register	All Devices	5.9	_	ns
t <sub>HPLL</sub>	Clock to Data Hold – PIO Input Register	All Devices	-0.6	_	ns

<sup>1.</sup> All the data is from the worst case condition.

<sup>2.</sup> LVCMOS timing measured with the load specified in Switching Test Condition table.

<sup>3.</sup> Commercial timing numbers are shown.



# SPI Master or NVCM Configuration Time<sup>1, 2</sup>

Symbol	Parameter	Conditions	Max.	Units
		All devices – Low Frequency (Default)	95	ms
t <sub>CONFIG</sub>	OON IQ =	All devices – Medium frequency	35	ms
		All devices – High frequency	18	ms

<sup>1.</sup> Assumes sysMEM Block is initialized to an all zero pattern if they are used.

### sysCONFIG Port Timing Specifications

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
All Configurat	tion Modes			l		I
t <sub>CRESET_B</sub>	Minimum CRESET_B LOW pulse width required to restart configuration, from falling edge to rising edge		200	_	_	ns
t <sub>DONE_IO</sub>	Number of configuration clock cycles after CDONE goes HIGH before the PIO pins are activated		49	_	_	Clock Cycles
Slave SPI	,			l		I
<sup>t</sup> cr_sck	Minimum time from a rising edge on CRESET_B until the first SPI WRITE operation, first SPI_XCK clock. During this time, the iCE40 Ultra device is clearing its internal configuration memory		1200	_	_	μѕ
ſ	OOLK alask for succession	Write	1	_	25	MHz
f <sub>MAX</sub>	CCLK clock frequency	Read <sup>1</sup>	_	15	_	MHz
t <sub>CCLKH</sub>	CCLK clock pulsewidth HIGH		20	_	_	ns
t <sub>CCLKL</sub>	CCLK clock pulsewidth LOW		20	_	_	ns
t <sub>STSU</sub>	CCLK setup time		12	_	_	ns
t <sub>STH</sub>	CCLK hold time		12	_	_	ns
t <sub>STCO</sub>	CCLK falling edge to valid output		13	_	_	ns
Master SPI <sup>3</sup>					•	
_		Low Frequency (Default)	7.0	12.0	17.0	MHz
f <sub>MCLK</sub>	MCLK clock frequency	Medium Frequency <sup>2</sup>	21.0	33.0	45.0	MHz
		High Frequency <sup>2</sup>	33.0	53.0	71.0	MHz
t <sub>MCLK</sub>	CRESET_B HIGH to first MCLK edge		1200	_	_	μs
t <sub>SU</sub>	CCLK setup time <sup>4</sup>		9.9	_	_	ns
t <sub>HD</sub>	CCLK hold time		1	_	_	ns

<sup>1.</sup> Supported with 1.2 V Vcc and at 25 °C.

<sup>2.</sup> The NVCM download time is measured with a fast ramp rate starting from the maximum voltage of POR trip point.

<sup>2.</sup> Extended range fMAX Write operations support up to 53 MHz with 1.2 V Vcc and at 25 °C.

<sup>3.</sup> t<sub>SU</sub> and t<sub>HD</sub> timing must be met for all MCLK frequency choices.

<sup>4.</sup> For considerations of SPI Master Configuration Mode, please refer to TN1248, iCE40 Programming and Configuration.



# Pinout Information iCE40 Ultra Family Data Sheet

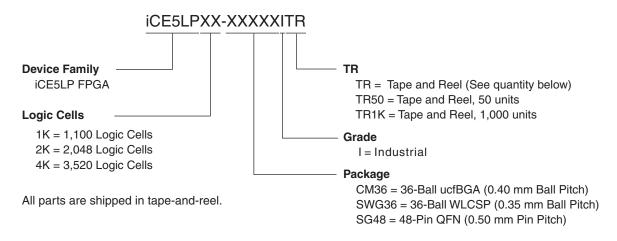
Signal Name	Function	I/O	Description
RGB2	General I/O	Open-Drain I/O	In user mode, with user's choice, this pin can be programmed as open drain I/O in user function
	LED	Open-Drain Output	In user mode, with user's choice, this pin can be programmed as open drain 24mA output to drive external LED
IRLED	General I/O	Open-Drain I/O	In user mode, with user's choice, this pin can be programmed as open drain I/O in user function
	LED	Open-Drain Output	In user mode, with user's choice, this pin can be programmed as open drain 500mA output to drive external LED
PIOT_xx	General I/O	I/O	In user mode, with user's choice, this pin can be programmed as I/O in user function in the top $(xx = I/O   location)$
PIOB_xx	General I/O	I/O	In user mode, with user's choice, this pin can be programmed as I/O in user function in the bottom ( $xx = I/O$ location)



# iCE40 Ultra Family Data Sheet Ordering Information

June 2016 Data Sheet DS1048

# **iCE5LP Part Number Description**



### **Tape and Reel Quantity**

Package	TR Quantity
CM36	4,000
SWG36	5,000
SG48	2,000



# **Ordering Part Numbers**

### Industrial

Part Number	LUTs	Supply Voltage	Package	Pins	Temp.
iCE5LP1K-CM36ITR	1100	1.2 V	Halogen-Free ucfBGA	36	IND
iCE5LP1K-CM36ITR50	1100	1.2 V	Halogen-Free ucfBGA	36	IND
iCE5LP1K-CM36ITR1K	1100	1.2 V	Halogen-Free ucfBGA	36	IND
iCE5LP1K-SWG36ITR	1100	1.2 V	Halogen-Free WLCSP	36	IND
iCE5LP1K-SWG36ITR50	1100	1.2 V	Halogen-Free WLCSP	36	IND
iCE5LP1K-SWG36ITR1K	1100	1.2 V	Halogen-Free WLCSP	36	IND
iCE5LP1K-SG48ITR	1100	1.2 V	Halogen-Free QFN	48	IND
iCE5LP1K-SG48ITR50	1100	1.2 V	Halogen-Free QFN	48	IND
iCE5LP2K-CM36ITR	2048	1.2 V	Halogen-Free ucfBGA	36	IND
iCE5LP2K-CM36ITR50	2048	1.2 V	Halogen-Free ucfBGA	36	IND
iCE5LP2K-CM36ITR1K	2048	1.2 V	Halogen-Free ucfBGA	36	IND
iCE5LP2K-SWG36ITR	2048	1.2 V	Halogen-Free WLCSP	36	IND
iCE5LP2K-SWG36ITR50	2048	1.2 V	Halogen-Free WLCSP	36	IND
iCE5LP2K-SWG36ITR1K	2048	1.2 V	Halogen-Free WLCSP	36	IND
iCE5LP2K-SG48ITR	2048	1.2 V	Halogen-Free QFN	48	IND
iCE5LP2K-SG48ITR50	2048	1.2 V	Halogen-Free QFN	48	IND
iCE5LP4K-CM36ITR	3520	1.2 V	Halogen-Free ucfBGA	36	IND
iCE5LP4K-CM36ITR50	3520	1.2 V	Halogen-Free ucfBGA	36	IND
iCE5LP4K-CM36ITR1K	3520	1.2 V	Halogen-Free ucfBGA	36	IND
iCE5LP4K-SWG36ITR	3520	1.2 V	Halogen-Free WLCSP	36	IND
iCE5LP4K-SWG36ITR50	3520	1.2 V	Halogen-Free WLCSP	36	IND
iCE5LP4K-SWG36ITR1K	3520	1.2 V	Halogen-Free WLCSP	36	IND
iCE5LP4K-SG48ITR	3520	1.2 V	Halogen-Free QFN	48	IND
iCE5LP4K-SG48ITR50	3520	1.2 V	Halogen-Free QFN	48	IND



# iCE40 Ultra Family Data Sheet Supplemental Information

October 2014 Data Sheet DS1048

### For Further Information

A variety of technical notes for the iCE40 Ultra family are available on the Lattice web site.

- TN1248, iCE40 Programming and Configuration
- TN1274, iCE40 SPI/I2C Hardened IP Usage Guide
- TN1276, Advanced iCE40 SPI/I2C Hardened IP Usage Guide
- TN1250, Memory Usage Guide for iCE40 Devices
- TN1251, iCE40 sysCLOCK PLL Design and Usage Guide
- TN1252, iCE40 Hardware Checklist
- TN1288, iCE40 LED Driver Usage Guide
- TN1295, DSP Function Usage Guide for iCE40 Devices
- TN1296, iCE40 Oscillator Usage Guide
- iCE40 Ultra Pinout Files
- iCE40 Ultra Pin Migration Files
- Thermal Management document
- Lattice design tools
- Schematic Symbols



Date	Version	Section	Change Summary
April 2015	1.7	Architecture	Updated sysDSP section. Revised the following figures:  — Figure 2-5, sysDSP Functional Block Diagram (16-bit x 16-bit Multiply-Accumulate)  — Figure 2-6, sysDSP 8-bit x 8-bit Multiplier  — Figure 2-7, DSP 16-bit x 16-bit Multiplier
		Ordering Information	Updated iCE5LP Part Number Description section. Added TR items.
			Updated Ordering Part Numbers section. Added CM36, SW36 and SG48 part numbers.
March 2015	1.6	Introduction	Updated Features section.  — Added BGA and QFN packages in Flexible Logic Architecture.  — Added USB 3.1 Type C Cable Detect / Power Delivery Applications in Applications.  — Updated Table 1-1, iCE40 Ultra Family Selection Guide. Added 36-ball ucfBGA and 48-ball QFN packages. Changed subheading to Total User I/O Count. Changed RBW IP to PWM IP. Deleted footnotes.
		DC and Switching Characteristics	Updated Power-up Sequence section. Indicated all devices in second paragraph.
			Updated sysIO Single-Ended DC Electrical Characteristics section. Changed LVCMOS 3.3 and LVCMOS 2. 5 V <sub>OH</sub> Min. (V) from 0.5 to 0.4.
			Replaced the Differential Comparator Electrical Characteristics table.
		Pinout Information	Updated Pin Information Summary section.  — Added CM36 and SG48 values.  — Changed CRESET_B to Dedicated Config Pins.
		Ordering Information	Updated iCE5LP Part Number Description section.  — Added CM36 and SG48 package.  — Added TR items.
			Updated Ordering Part Numbers section. Added CM36, SW36 and SG48 part numbers.
October 2014	1.5	Introduction	Updated Features section.  — Removed 26 I/O pins for 36-pin WLCSP under Flexible Logic Architecture.  — Changed form factor to 2.078 mm x 2.078 mm.  — Updated Table 1-1, iCE40 Ultra Family Selection Guide. Removed 20-Ball WLCSP.
			Updated Introduction section. Changed form factor to 2.078 mm x 2.078 mm.
		Architecture	Updated sysCLOCK Phase Locked Loops (PLLs) section. Removed note in heading regarding sysCLOCK PLL support.
		DC and Switching Characteristics	Updated Recommended Operating Conditions section. Removed footnote on sysCLOCK PLL support.
			Updated Power-up Sequence section. Removed information on 20-pin WLCSP.
		Pinout Information	Updated Signal Descriptions section. Removed references 20-pin WLCSP.
			Updated Pin Information Summary section. Removed references to UWG20 values.
		Ordering Information	Updated iCE5LP Part Number Description section. Removed 20-ball WLCSP.
			Updated Ordering Part Numbers section. Removed UWG20 part numbers.
		Further Information	Added technical note references.



Date	Version	Section	Change Summary
August 2014	1.4	All	Removed Preliminary document status.
		Introduction	Updated General Description section. Added information on high current driver.
			Updated Features section.  — Changed standby current typical to as low as 71 μA.  — Changed feature to Embedded Memory.  — Updated Table 1-1, iCE40 Ultra Family Selection Guide. Added NVCM and Embedded PWM IP rows. Added (MULT16 with 32-bit Accumulator) to DSP Block. Added Total I/O (Dedicated I/O) Count data.
			General update to Introduction section.
		Architecture	Updated Architecture Overview section.  — Revised and added information on sysIO banks.  — Updated reference for embedded PWM IP.
			Updated iCE40 Ultra Programming and Configuration section.  — Changed SPI1 to SPI.  — Changed VCCIO_1 to SPI_V <sub>CCIO1</sub> .
		DC and Switching Characteristics	Updated Absolute Maximum Ratings section. Changed PLL Supply Voltage VCCPLL value.
			Updated Recommended Operating Conditions section. Added footnote to VCCPLL.
			Updated Power-up Sequence section. General update.
			Updated Power-On-Reset Voltage Levels section. Changed the $V_{PORUP}$ $V_{CC}$ Max.value.
			Updated DC Electrical Characteristics section. Added $C_3$ and $C_4$ information.
			Updated Supply Current section.  — Completed Typ. VCC =1.2 V4 data.  — Changed symbols to I <sub>SPI_VCCIO1STDBY</sub> and I <sub>SPI_VCCIO1PEAK</sub> .  — Added information to footnote 3.
			Updated Internal Oscillators (HFOSC, LFOSC) section. General update.
			Updated iCE40 Ultra External Switching Characteristics section. Added Max. value for t <sub>COPLL</sub> . Added Min. values for t <sub>SUPLL</sub> and t <sub>HPLL</sub> .
			Updated sysCLOCK PLL Timing section. Added Max. value for t <sub>OPJIT</sub> .
			Updated sysCONFIG Port Timing Specifications section.  — Added T <sub>SU</sub> and T <sub>HD</sub> information.  — Added footnote 3 to Master SPI.
			Updated High Current LED and IR LED Drive section. Updated Min. value.
July 2014	1.3	All	Changed document status from Advance to Preliminary.
		Introduction	Updated Features section. Adjusted Ultra-low Power Devices standby current.
		DC and Switching Characteristics	Updated AC/DC specifications numbers.